Dalitz plot analysis of  $D^0 \rightarrow K_S \pi^- \pi^+$ using K-matrix formalism

Luigi Li Gioi Università di Roma "La Sapienza" & INFN Roma

for the "D<sup>0</sup>K Dalitz" group

Charm Working Group Meeting 2005 July 21



- $M(K_s) = [0.35, 0.65] \text{ GeV/c}^2$
- $K_s$  vertex fit:  $\chi^2$ /ndof > 0.001
- K<sub>s</sub> mass constraint
- $D^0 K_s$  vtx. distance > 0.4 cm •  $cos(\alpha(K_s)) > 0.7$
- $D^0$  vertex fit:  $\chi^2$ /ndof > 0.001
- $D^0$  momentum > 2.2 GeV/c
- D<sup>0</sup> mass constraint

- $D^*$  vertex fit:  $\chi^2$ /ndof > 0.001
- slow  $\pi$  momentum < 0.6 GeV/c
- ChargedTracks list used for the  $2\pi$  from the K<sub>s</sub> and for the slow

#### pion

- GoodTracksLoose used for the 2  $\pi$  from the D<sup>0</sup>
- TreeFitter used in all vertex fits

## RUN 1 – 4 selection (II)



•  $\Delta m$  fitted with 2 Gaussians (signal) + threshold function (background)

- $\bullet$  Cut 1.4 MeV/c² (~2\sigma) around the mean value
- $M(D^0)$  fitted with 2 Gaussians (signal) + first order polynomial (background)
- Cut  $2\sigma$  (~11 MeV/c<sup>2</sup>) around the mean value



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### Background composition



Sample	Selected $M_D$ region	% of events
$D^0 \rightarrow K^0_s \pi^+ \pi^-$	264228	96.7
$c\bar{c}$	5576	2.0
uds	1513	0.6
$B^0 \bar{B^0}$	1484 (895)	0.5(0.3)
$B^+B^-$	521 (209)	0.2(0.1)
$D^0 \rightarrow K^0_s \pi^+ \pi^- \pi^0$	628	0.2

$$() = D^0 \to K_{\rm s} \pi^- \pi^+$$



- good Data–MC agreement
- no dominant background
- from MC S/(S+B)=97.1 % close to the one obtained from data (97.7 %)
- we use the value from data

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## Background parametrization (I)

Use of the M(D<sup>0</sup>) sidebands for the background parametrization



The two distributions are a bit different.

Bkg parametrization and relative systematic still not decided

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## **Background parametrization (II)**



Test the effect on the fit of the bkg parametrization using the sum of the two sidebands

### 3.5 % of signal events in the sidebands

parametrization of the sidebands with a  $3^{rd}$  order polinomial plus  $|\Sigma_1^{\ 6} BW_i|^2$  for background and with the B-W fit (see later) for the signal events

since B/(S+B)=2.3 % we expect a small systematic

(c)  $M^2_{\pi^+\pi^-}$ 

(d) Dalitz plot of the sideband events

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## Efficiency map



fit resultflat distribution

#### Phase space signal MC used

parametrization with a 3<sup>rd</sup> order polinomial

the efficiency map is very close to a flat distribution

systematic with a flat distribution

(c)  $M^2_{\pi^+\pi^-}$ 

(d) Dalitz distribution

# Breit Wigner Fit

hep-ex/0504039



Run1-2 selection (Run1-4 fit ongoing)  $\Sigma$ (fit fraction)=124.5 %

**σ**(m=484±9 MeV, **Γ**=383±14 MeV) **σ**'(m=1014±7MeV, **Γ**=88±13MeV)

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### K matrix formalism

K-matrix describe the unitarity of the S matrix in processes  $a \; b \to c \; d$ 

$$S = 1 + 2i\sqrt{\rho}T\sqrt{\rho}$$

T = transition operator

ρ = phase space matrix (diagonal matrix)

$$S^{+}S = SS^{+} = 1 \Rightarrow (T^{-1} + i\rho)^{+} = (T^{-1} + i\rho)^{+}$$

defining  $K^{-1} = (T^{-1} + i \rho)$   $K = K^+$  (K hermitian)

Use of the isobar model to apply the K-matrix to Dalitz amplitude



### K matrix: $\pi\pi$ S-wave

Parametrize the S-wave component using K matrix formalism

$$\mathbf{F}_{l} = (\mathbf{I} - i \mathbf{K} \boldsymbol{\rho})^{-1} \mathbf{l} \mathbf{j} \mathbf{P}_{j}$$

j,l = 1....N N= number of modes considered modes(i,j):  $\pi\pi$ , KK,  $4\pi$ ,  $\eta\eta$ ,  $\eta\eta'$ 

F = amplitude vector ρ = phase space matrix (diagonal matrix) P = "imitial" production matrix

**P** = "initial" production vector

Following the parametrization of: V.V. Anisovich, A.V. Sarantsev (Eur.Phys.J.A16:229-258,2003)

$$K_{ij}(s) = \left\{ \sum_{\alpha} \frac{g_i^{(\alpha)} g_j^{(\alpha)}}{m_{\alpha}^2 - s} + f_{ij}^{scatt.} \frac{1 \, GeV^2 - s_0^{scatt.}}{s - s_0^{scatt.}} \right\} \frac{1 - s_{A0}}{s - s_{A0}} (s - s_A m_{\pi}^2/2)$$
Pole term
Smooth part
Alder zero term

K matrix poles( $\alpha$ ): f<sub>0</sub>(980), f<sub>0</sub>(1300), f<sub>0</sub>(1200 - 1600), f<sub>0</sub>(1500), f<sub>0</sub>(1750)

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### F-vector

The  $\pi\pi$  component of the **F** vector:

$$F_{1} = (I - iK\rho)_{1j}^{-1} \left\{ \sum_{\alpha} \frac{\beta_{\alpha} g_{j}^{(\alpha)}}{m_{\alpha}^{2} - s} \underbrace{f_{1j}^{prod.}}_{s - s_{0}^{prod.}} \frac{1 \, GeV^{2} - s_{0}^{prod.}}{s - s_{0}^{prod.}} \right\} \frac{1 - s_{A0}}{s - s_{A0}} (s - s_{A} m_{\pi}^{2}/2)$$

 $\beta_{\alpha}$  and  $f_{1j}^{prod}$  are free parameters in our fit  $s_0^{prod} = s_0^{scatt}$  so far the "zero term" can be omitted in the P vector

The transition matrix:  $T = (I - i K \rho)^{-1} K$ 



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### **K-Matrix parametrization**



## Fit result (I)



- Values of mass and wight of B.-W. terms fixed to the P.D.G. 2004 values.
- Amplitudes and phases of B.-W. terms floated.
- Parameter of the Production vector floated
- Parameter on the K-matrix fixed.

### Fit result (II)



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### Background effect

	flat bkg val.	flat bkg err	fit bkg val	fit-bkg err	pull
Kst1410 lm	-0.0	8 0.045	-0.084	0.045	0.130
Kst1410_Re	-0.0	7 0.050	-0.067	0.049	0.092
K2*1430_DCS_Im	-0.13	3 0.021	-0.126	6 0.021	0.115
K2*1430_DCS_Re	0.03	3 0.022	0.03	<b>0.022</b>	0.118
K2*1430_Im	-0.5	5 0.029	-0.559	0.029	0.174
K2*1430_Re	0.84	4 0.022	0.846	0.022	0.301
Kst1430_DCS_Im	-0.1	7 0.037	-0.190	0.037	0.362
Kst1430_DCS_Re	0.4	1 0.034	0.42	2 0.034	0.150
Kst1430_lm	-0.1	5 0.046	-0.467	0.047	0.433
Kst1430_Re	2.8	1 0.042	2.808	3 0.042	0.057
Kst1680_lm	1.13	3 0.245	1.129	0.244	0.012
Kst1680_Re	- 5 . 04	4 0.174	-5.02:	0.1/3	0.054
Kstminus_Im	1.3	3 0.011	1.320	6 0.011	0.330
Kstminus_Re	-1.3	1 0.012	-1.10	0.012	0.314
Kstplus_Im	-0.12	2 0.004	-0.125	0.004	0.154
Kstplus_Re	0.1	1 0.004	0.110	0.004	0.442
f2_1270_lm	-0.(	6 0.032	-0.604	4 0.032	0.197
f2_1270_Re	0.70	6 0.024	0.769	0.023	0.180
omega782_lm	0.0	3 0.001	0.03	L 0.001	0.203
omega782_Re	-0.02	2 0.001	-0.020	0.001	0.227
rho1450_lm	-0.19	9 0.087	-0.201	0.086	0.101
rho1450_Re	1.2	2 0.048	3 1.194	4 0.049	0.404
beta1_Im	0.29	9 0.141	0.32	0.14	0.110
beta1_Re	-2.82	2 0.119	-2.89	0.12	0.417
beta2_Im	4.22	2 0.226	6 4.23	0.23	0.023
beta2_Re	8.29	9 0.148	8 8.43	3 0.15	0.639
beta3_Im	5.05	5 1.901	5.64	l 1.91	0.222
beta3_Re	2.69	9 1.333	3 3.26	5 1.34	0.303
beta4_Im	1.44	4 0.217	1.35	o 0.22	0.270
beta4_Re	7.5	5 0.236	5 7.68	3 0.24	0.545
fp1_lm	-9.63	1 0.276	-9.67	0.28	0.146
fp1_Re	-7.13	3 0.282	-7.28	3 0.28	0.389
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use of cartesian coordinates to better evaluate the low amplitudes component

the value are differs less than 1  $\sigma$  changing bkg parametrization

### Fit fractions

K-M fit [%] B-W fit [%]

Rho770	23.28	22.33
Kst1410	0.01	0.39
K2*1430_DCS	0.04	0.01
K2*1430	2.30	2.70
Kst1430_DCS	0.28	0.60
Kst1430	11.46	8.37
Kst1680	6.46	0.35
Kstminus	60.25	58.51
Kstplus	0.54	0.59
F2_1270	2.99	2.95
Omega782	0.52	0.56
Rho1450	1.05	0.28
S-wave	14.20	19.29
NonReson		6.82
SUM	123.39	123.75

the sum of the fit fraction is quite similar in the two fits

The S-wave fit fraction is larger in the BW fit as expected

### Fit problems



### **Resolution function**





Resolution function evaluated as a function of the Dalitz plot.

m<sub>ij</sub>(gen.)-m<sub>ij</sub>(rec.) fitted
 with 2 gaussians in
 bins of the Dalitz plot

a maximum of the smearing effect is present in the region of K\*(890) CA and DCS

## Smearing effect

Generate a sample of K<sup>\*</sup>(892) or ω(782)
Smear the sample according to the resolution function

• Fit the generated and the smeared samples

parameter	generated	smeared	
$K^{*}(892)$ mass	$8.9222e-01 \pm 8.00e-05$	$8.9348e-01 \pm 8.02e-05$	
$K^*(892)$ width	$5.1208e-02 \pm 1.86e-04$	$5.1232e-02 \pm 1.86e-04$	
$\omega(782)$ mass	$7.8246e-01 \pm 1.48e-05$	$7.8053e-01 \pm 1.36e-05$	
$\omega(782)$ width	$8.8380\text{e-}03 \pm 2.67\text{e-}05$	$8.8995\text{e-}03 \pm 2.93\text{e-}05$	

#### Kst distribution



- Negligible effect on the width
- $\bullet$  1.3 (2.1) MeV/c² shift for the  $K^*(892)~(\omega(782))$  mass

5000

0.45

0.5

0.55

0.65

0.7

M^2(Pi+ Pi-) [Gev^2]

0.75

0.6

omega: green=generated vellow=smeared

generated

smeared

• Low  $\omega(782)$  amplitude, neglect the affect

0.003

• Shift the K\*(892) mass



#### K– $\pi$ S–wave: K–matrix

V.V. Anisovich, A.V. Sarantsev (Phys. Lett. B 413 (1997) 137-146)



problem: defined in [0.9–2.1] GeV/c<sup>2</sup>



modes(i,j): K  $\pi$ , K  $\eta'$ , K  $3\pi$ 2 poles: 1.16, 1.89 GeV/c<sup>2</sup>



Better hight  $m(K_s \pi)$ value description

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#### K– $\pi$ S–wave from D decays

K– $\pi$  S–wave extracted from A.Palano in D<sup>+</sup>  $\rightarrow$  K<sup>-</sup>  $\pi^+\pi^+$  decay

problems: errors not available, impossible to separate the different production component.



## $\chi^2$ evaluation

• The  $\chi^2$  value depend from the binning then is impossible to give to the  $\chi^2$  a meaning of goodness of fit • Anyhow the  $\chi^2$  can be used to select from different models.

Starting with a 300x300 bins in the Dalitz plot and then merging the bins until having more than 10 events per bin:

for the fit with **flat background**:

 $\chi^2 = 6640/(3970-32) = 1.69$ 

for the fit with **sidebands background**:

 $\chi^2 = 6593/(3970-32) = 1.67$ 

### Conclusion

- Run 1-4 selection give more than 25000 events
- Purity of the sample 97.7 %
- Absence of  $M(D^0)$  peaking background, it is possible to use the  $M(D^0)$  sidebands to parametrize the background
- The indetermination of the background shape can be taken into account with a systematic (2.3 % of background).
- The V.V. Anisovich, A.V. Sarantsev  $\pi\pi$  S-wave parametrization works fine for the  $D^0 \rightarrow K_s \pi^-\pi^+$  decay.
- Problem in the  $K^*(890)$  shape, maybe due to resolution effects. Try to shift  $K^*(890)$  mass.
- Problem in the hight  $m(K_{s} \pi^{-})$  value maybe due to K- $\pi$  S-wave
- A satisfactory K- $\pi$  S-wave parametrization not present, work ongoing.
- Final model still not decided, a  $\chi^2$  can help to select a model.
- Documentation in BAD #1237